Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10583181	D'AMATO, GIANFRANCO
Examiner	Art Unit
CHRISTOPHER DEMEREE	3782

SEARCHED				
Class	Subclass	Date	Examiner	
229	4.5, 932	1/12/2009	CD	
206	562	12/29/2009	CD	
220	665, 680, 678, 676, 670, 659, 657, 656	12/30/2009	CD	

SEARCH NOTES			
Search Notes	Date	Examiner	
Conducted a PLUS search on the application	1/12/2009	CD	
Conducted a text search for (tamper or inspection) and B65D 3/6	1/12/2009	CD	
Updated search	7/7/2009	CD	
Consulted examiner, Robert Hicks, for search assistance in class 220. Subclasses 665, 662, 680, 678, 676, 670, 669, 62, 659, 657 and 656 were suggested.	12/30/2009	CD	
Conducted a text search for ((peripheral or edge) near5 (hole or opening or aperture)) with overlap\$4) AND (229.clas. or 220.clas. or 206.clas.)	12/29/2009	CD	
Conducted a text search for ((recess\$3 or open\$3) with (edge or peripher\$2)) AND (220/662 or 220/669 or 220/62)	12/30/2009	CD	

INTERFERENCE SEARCH		
Subclass	Date	Examiner

/CHRISTOPHER DEMEREE/ Examiner.Art Unit 3782	

U.S. Patent and Trademark Office Part of Paper No.: 20100107